

60 V, 2.7 A PNP low V_{CEsat} (BISS) transistor Rev. 02 — 9 March 2010

Product data sheet

1. **Product profile**

1.1 General description

PNP low V_{CEsat} Breakthrough In Small Signal (BISS) transistor in a SOT23 (TO-236AB) small Surface-Mounted Device (SMD) plastic package.

NPN complement: PBSS4041NT.

1.2 Features and benefits

- Very low collector-emitter saturation voltage V_{CEsat}
- High collector current capability I_C and I_{CM}
- High collector current gain (h_{FE}) at high I_C
- High energy efficiency due to less heat generation
- AEC-Q101 qualified
- Smaller required Printed-Circuit Board (PCB) area than for conventional transistors

1.3 Applications

- Loadswitch
- Battery-driven devices
- Power management
- Charging circuits
- Power switches (e.g. motors, fans)

1.4 Quick reference data

Table 1. **Quick reference data**

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V_{CEO}	collector-emitter voltage	open base	-	-	-60	V
I _C	collector current		-	-	-2.7	А
I _{CM}	peak collector current	single pulse; $t_p \leq 1 \text{ ms}$	-	-	-8	A
R _{CEsat}	collector-emitter saturation resistance	I _C = -3 A; I _B = -300 mA	<u>[1]</u> _	80	120	mΩ

[1] Pulse test: $t_p \le 300 \ \mu s$; $\delta \le 0.02$.



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2. Pinning information

Table 2.	Pinning		
Pin	Description	Simplified outline	Graphic symbol
1	base		
2	emitter		3
3	collector		
			sym013

3. Ordering information

Table 3. Order	ring inform	ation		
Type number	Package)		
	Name	Description	Version	
PBSS4041PT	-	plastic surface-mounted package; 3 leads	SOT23	

4. Marking

Table 4. Marking codes	
Type number	Marking code ^[1]
PBSS4041PT	*BL
[1] * = -: made in Hong Kong	

- * = p: made in Hong Kong
- * = t: made in Malaysia
- * = W: made in China

5. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V _{CBO}	collector-base voltage	open emitter	-	-60	V
V _{CEO}	collector-emitter voltage	open base	-	-60	V
V _{EBO}	emitter-base voltage	open collector	-	-5	V
I _C	collector current		-	-2.7	А
I _{CM}	peak collector current	single pulse; $t_p \leq 1 ms$	-	-8	A
I _B	base current		-	-1	А

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Table 5.	Limiting	values	continued
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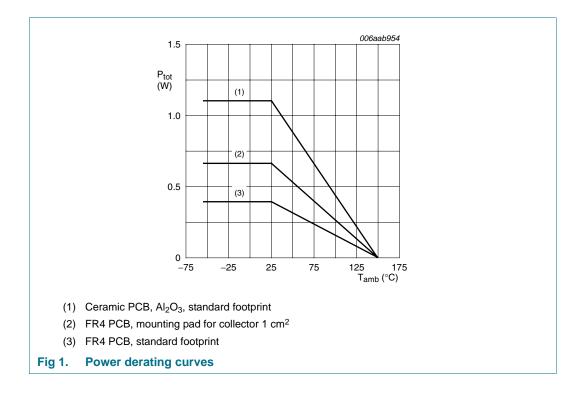
In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
P _{tot}	total power dissipation	$T_{amb} \le 25 \ ^{\circ}C$	<u>[1]</u> _	390	mW
			[2] _	660	mW
			[3] _	1100	mW
Tj	junction temperature		-	150	°C
T _{amb}	ambient temperature		-55	+150	°C
T _{stg}	storage temperature		-65	+150	°C

[1] Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.

[2] Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for collector 1 cm².

[3] Device mounted on a ceramic PCB, AI_2O_3 , standard footprint.



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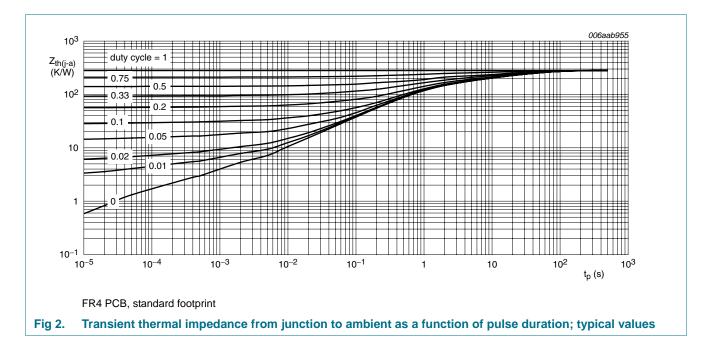
6. Thermal characteristics

Table 6.	Thermal characteristics					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
R _{th(j-a)}	thermal resistance from junction to ambient	in free air	<u>[1]</u> _	-	320	K/W
			[2] _	-	190	K/W
			<u>[3]</u> _	-	115	K/W
R _{th(j-sp)}	thermal resistance from junction to solder point		-	-	62	K/W

[1] Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.

[2] Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for collector 1 cm².

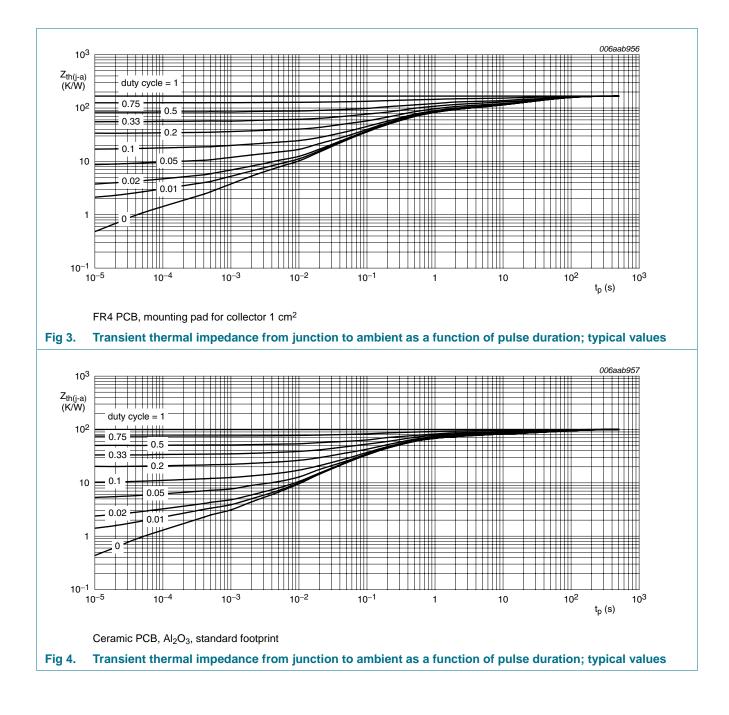
[3] Device mounted on a ceramic PCB, Al_2O_3 , standard footprint.



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7. Characteristics

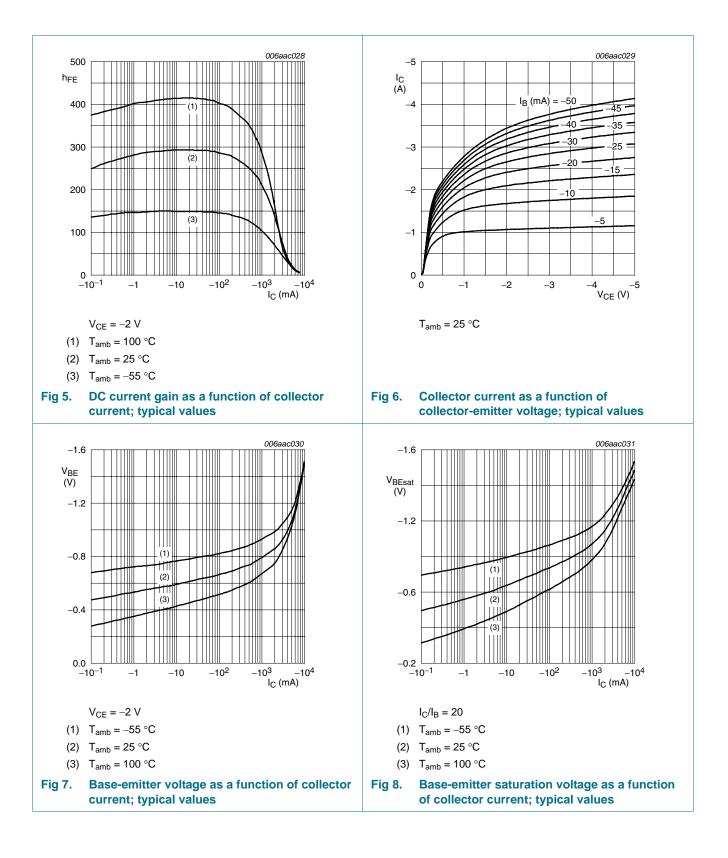
Symbol	Parameter	Conditions		Min	Тур	Max	Unit
I _{CBO}	collector-base cut-off	$V_{CB} = -60 \text{ V}; I_E = 0 \text{ A}$		-	-	-100	nA
	current	$\label{eq:VCB} \begin{split} V_{CB} &= -60 \text{ V}; \text{ I}_E = 0 \text{ A}; \\ T_j &= 150 \ ^\circ\text{C} \end{split}$		-	-	-55	μΑ
I _{CES}	collector-emitter cut-off current	$V_{CE} = -48 \text{ V}; \text{V}_{BE} = 0 \text{ V}$		-	-	-100	nA
I _{EBO}	emitter-base cut-off current	$V_{EB} = -5 \text{ V}; \text{ I}_{C} = 0 \text{ A}$		-	-	-100	nA
h _{FE}	DC current gain	V_{CE} = -2 V; I_{C} = -500 mA		200	300	-	
		$V_{CE} = -2 \text{ V}; \text{ I}_{C} = -1 \text{ A}$	[1]	150	270	-	
		$V_{CE} = -2 \text{ V}; \text{ I}_{C} = -2 \text{ A}$	[1]	120	180	-	
		$V_{CE} = -2 \text{ V}; \text{ I}_{C} = -4 \text{ A}$	[1]	35	55	-	
V _{CEsat} collector-emitter saturation voltage		$I_{C} = -500 \text{ mA};$ $I_{B} = -50 \text{ mA}$		-	-49	-75	mV
		$I_{C} = -1 \text{ A}; I_{B} = -50 \text{ mA}$	[1]	-	-100	-150	mV
		$I_{C} = -1 \text{ A}; I_{B} = -10 \text{ mA}$	[1]	-	-260	-390	mV
		$I_{C} = -2 \text{ A}; I_{B} = -40 \text{ mA}$	[1]	-	-420	-600	mV
		$I_{C} = -3 \text{ A}; I_{B} = -300 \text{ mA}$	[1]	-	-240	-360	mV
R _{CEsat}	collector-emitter saturation resistance	$I_{C} = -3 \text{ A}; I_{B} = -300 \text{ mA}$	[1]	-	80	120	mΩ
V _{BEsat}	base-emitter	$I_{C} = -1 \text{ A}; I_{B} = -100 \text{ mA}$	[1]	-	-0.9	-1.0	V
	saturation voltage	$I_{C} = -3 \text{ A}; I_{B} = -300 \text{ mA}$	[1]	-	-1.04	-1.15	V
V _{BEon}	base-emitter turn-on voltage	$V_{CE} = -2 \text{ V}; \text{ I}_{C} = -2 \text{ A}$		-	-0.84	-0.9	V
t _d	delay time	$V_{CC} = -12.5 \text{ V}; \text{ I}_{C} = -1 \text{ A};$		-	18	-	ns
t _r	rise time	$I_{Bon} = -0.05 \text{ A};$ $I_{Boff} = 0.05 \text{ A}$		-	70	-	ns
t _{on}	turn-on time	$B_{\text{Boff}} = 0.05 \text{ A}$		-	88	-	ns
t _s	storage time			-	350	-	ns
t _f	fall time			-	80	-	ns
t _{off}	turn-off time			-	430	-	ns
f _T	transition frequency	$V_{CE} = -10 \text{ V};$ $I_{C} = -100 \text{ mA};$ f = 100 MHz		-	150	-	MHz
C _c	collector capacitance	$V_{CB} = -10 \text{ V}; I_E = i_e = 0 \text{ A};$ f = 1 MHz		-	38	-	pF

 $\label{eq:point} \begin{tabular}{ll} \mbox{Pulse test: } t_p \leq 300 \ \mu \mbox{s; } \delta \leq 0.02. \end{tabular}$

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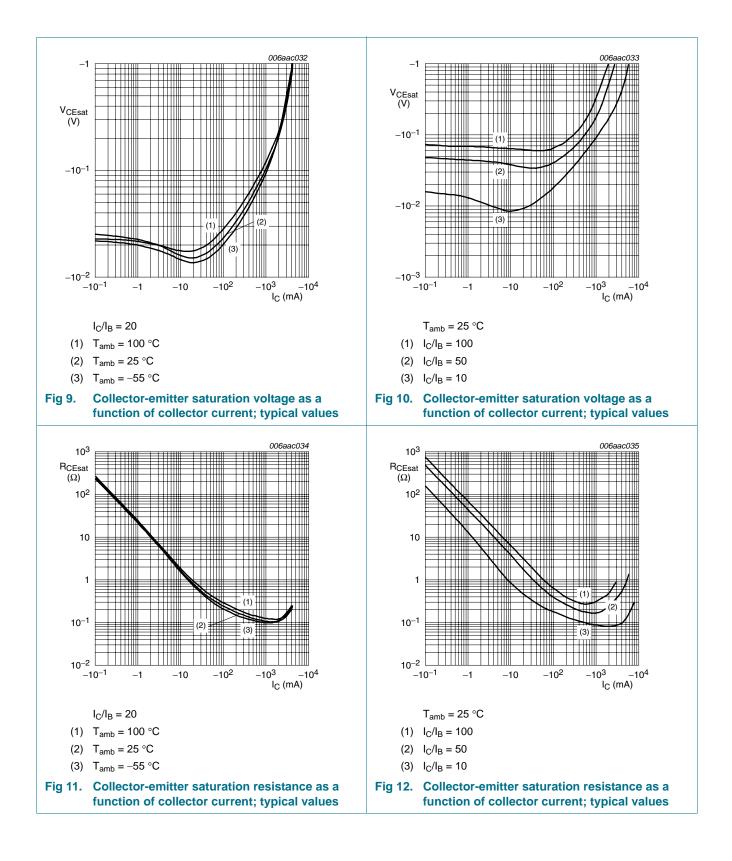
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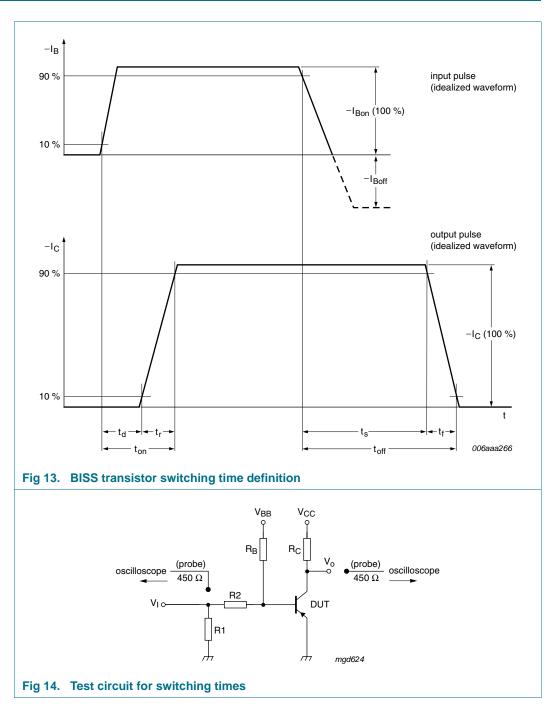
PBSS4041PT

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8. Test information

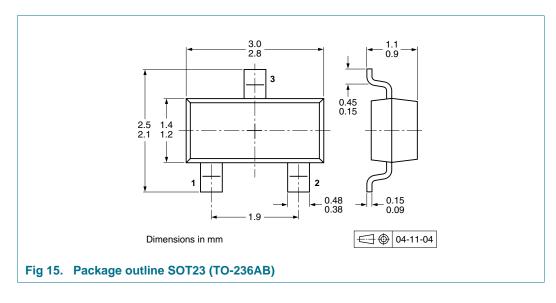


8.1 Quality information

This product has been qualified in accordance with the Automotive Electronics Council (AEC) standard *Q101* - *Stress test qualification for discrete semiconductors*, and is suitable for use in automotive applications.

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9. Package outline



10. Packing information

Table 8. Packing methods

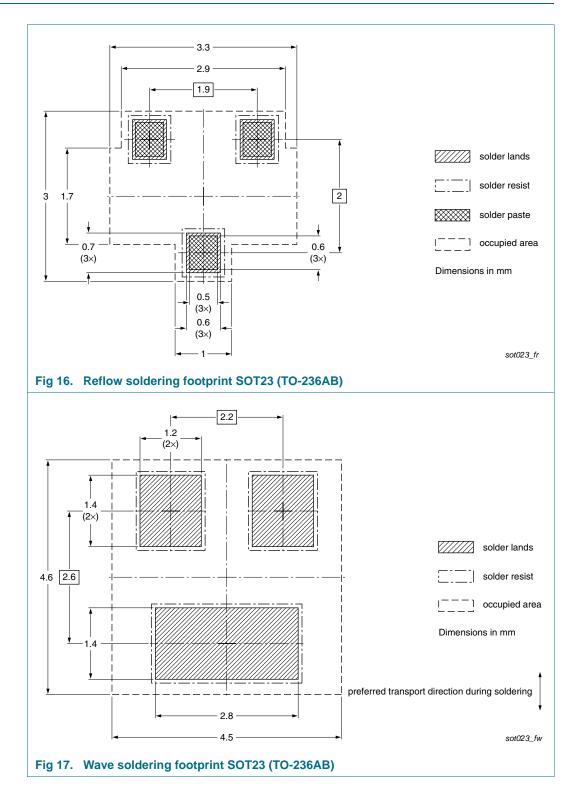
The indicated -xxx are the last three digits of the 12NC ordering code.[1]

Type number	Package	Description Packing qua		quantity	
				3000	10000
PBSS4041PT	SOT23	4 mm pitch, 8 mm tape and reel		-215	-235

[1] For further information and the availability of packing methods, see <u>Section 14</u>.

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11. Soldering



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12. Revision history

Table 9. Revision hi	story			
Document ID	Release date	Data sheet status	Change notice	Supersedes
PBSS4041PT_2	20100309	Product data sheet	-	PBSS4041PT_1
Modifications:	 Typo for V_{BE} 	_{Esat} maximum value amended		
PBSS4041PT_1	20100131	Product data sheet	-	-

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13. Legal information

13.1 Data sheet status

Document status[1][2]	Product status ^[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

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